

**Notice of References Cited**

Application/Control No.

10/808,110

Applicant(s)/Patent Under

Reexamination

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Examiner

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Art Unit

2195

Page 1 of 1

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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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